Docket No.: 0925-0220PUS1

(PATENT)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of: Satoshi YAMANAKA et al.

Application No.: NEW

Confirmation No.: N/A

Filed: July 7, 2005

Art Unit: N/A

For: PIXE

PIXEL INTERPOLATION CIRCUIT, PIXEL INTERPOLATION METHOD AND IMAGE

SCANNER

Examiner: Not Yet Assigned

INFORMATION DISCLOSURE STATEMENT (IDS)

MS PCT Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO/SB/08. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement accompanies the new patent application submitted herewith.

A summary/abstract translation of the non-English language references is enclosed.

Those documents which are marked with a double asterisk (**) next to the Cite No. in the attached form PTO/SB/08 (facsimile) are not supplied because they were previously cited by or submitted to the Office in a prior application number PCT/JP/2004/009179, filed June 30, 2004.

Birch Stewart Kolasch & Birch LLP

MRC/nl

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Application No.:

A concise explanation of relevance of the previously cited references is in the form of an English language copy of a Search Report from a foreign patent office, issued in a counterpart application, which refers to the relevant portions of the references.

In accordance with 37 CFR 1.97(g), the filing of this Information Disclosure Statement shall not be construed to mean that a search has been made or that no other material information as defined in 37 CFR 1.56(a) exists. In accordance with 37 CFR 1.97(h), the filing of this Information Disclosure statement shall not be construed to be an admission that any patent, publication or other information referred to therein is "prior art" for this invention unless specifically designated as such.

It is submitted that the Information Disclosure Statement is in compliance with 37 CFR 1.98 and the Examiner is respectfully requested to consider the listed references.

If necessary, the Commissioner is hereby authorized in this, concurrent, and future replies, to charge payment or credit any overpayment to our Deposit Account No. 02-2448 for any additional fees required under 37 C.F.R. § 1.16 or under § 1.17; particularly, extension of time fees.

Dated: July 7, 2005

Respectfully submitted,

Michael R. Cammarata Registration No.: 39,491

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10541611 - GAU: 2625

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Complete if Known Substitute for form 1449A/B/PTO July 7, 2005 Application Number INFORMATION DISCLOSURE Filing Date Satoshi YAMANAKA STATEMENT BY APPLICANT First Named Inventor Art Unit N/A (Use as many sheets as necessary) Not Yet Assigned Examiner Name 0925-0220PUS1 of 1 Attomey Docket Number Sheet

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No.	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear

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Examiner Signature	/Richard Zhu/	Date Considered	06/24/2008
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